

***Advances in Latent Class Analysis:
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G. R. Hancock & G. B. Macready (Eds.)

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Model selection in latent class regression models with concomitant variables

José G. Dias, Institute of Social Sciences and Business Studies, Portugal

Modeling structured multiple classification latent classes in multiple populations

Shirley Xu & Matthias von Davier, Educational Testing Service

On the measurement of non-compliance using randomized response models

Ulf Bockenholt, McGill University, Canada

Maarten Cruyff & Peter van der Heijden, Utrecht University, Netherlands

Multidimensional item response models:

Comparing normal and discrete ability distributions

Shelby J. Haberman, Matthias von Davier, & Yi-Hsuan Lee, Educational Testing Service

The use of graphs in latent variable modeling with categorical data: Beyond visualization

Frank Rijmen, Educational Testing Service

Mixtures of factor analyzers for the clustering and visualisation of high-dimensional data

Geoffrey J. McLachlan, University of Queensland, Australia

Jangsun Baek, Chonnam National University, Korea

Multimethod latent class analysis

Fridtjof W. Nussbeck, University of Zurich, Switzerland

Michael Eid, Free University of Berlin, Germany

Marginal modeling and latent class analysis

Jacques Hagenaars & Marcel Croon, Tilburg University, The Netherlands

Wicher Bergsma, London School of Economics and Political Science, England

Logistic regression with floor and ceiling effects: Fixed and random effects models

David Rindskopf, City University of New York

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Model based analysis of incomplete data using the mixture index of fit

Tamas Rudas, Eötvös Loránd University, Hungary

Emese Verdes, World Health Organization International

A critical historical perspective on diagnostic classification models:

Looking back, looking around, and looking forward

Jonathan Templin, University of Georgia

André A. Rupp, University of Maryland

Multilevel latent class models

Jeroen Vermunt, Tilburg University, The Netherlands

Jay Magidson, Statistical Innovations, Inc.

Advances in logistic regression for randomized response data

Peter G.M. van der Heijden, Utrecht University, Netherlands

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